Notice of References Cited	Application/Control No. 10/772,130	Applicant(s)/Patent Under Reexamination CHEN, JUN		
Notice of herefellees offed	Examiner	Art Unit	Page 1 of 1	
	JASON LIN	2425		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0049974 A1	04-2002	Shnier, J. Mitchell	725/47
*	В	US-2003/0093795 A1	05-2003	Takahashi et al.	725/49
*	O	US-6,883,176 B1	04-2005	Grooters, Brandon A.	725/39
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Ø					
	R					
	S					
	Т					_

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	<b>V</b>		
	w		
	х		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.